



Product Specification

RoHS compliant & Halogen Free Surface-mount Ceramic Multilayer Capacitors

Part Description: X5R/0402/4.7uF/10V/±20%

Yageo Part number : CC0402MRX5R6BB475





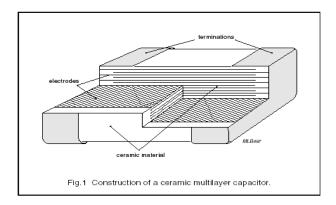
SCOPE

This product specification is applied to Multi-layer Ceramic Capacitor used for General Electronic equipment.

Description

The capacitor consists of a rectangular block of ceramic dielectric in which a number of interleaved nickel electrodes are contained. This structure gives rise to a high capacitance per unit volume.

The inner electrodes are connected to the two end terminations and finally covered with a layer of plated tin (NiSn). The terminations are lead-free. A cross section of the structure is shown in Fig.1.



MECHANICAL DATA

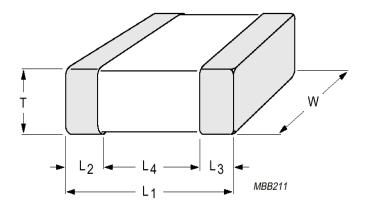


Fig. 2 Component outline

Physical dimensions (all in mm)

Size	1.1	W	т	L2	/L3	L4
3126	LI	VV	•	Min	Max	Min
0402	1.0 ±0.15	0.5 ±0.15	0.5±0.15	0.20	0.30	0.40

Thickness classification and packaging quantities:

Thickness Classification	Tape Width	Amount
0.5±0.15 mm	Paper/PE tape reel 7"	10,000





ELECTRICAL CHARACTERISTICS

Unless otherwise specified, all test and measurements shall be made under standard atmospheric conditions for testing as given in 5.3 of IEC 60068-1:

--temperature: 15°C to 35°C --relative humidity: 25% to 75% --air pressure: 86 kPa to 106 kPa

Before the measurements are made, the capacitor shall be stored at the measuring temperature for a time sufficient to allow the entire capacitor to reach this temperature. The period as prescribed for recovery at the end of a test is normally sufficient for this purpose.

Capacitance range	4.7uF
Temperature range	-55 °C to +85 °C
Tolerance on capacitance after 1000 hours	±20%
Rated voltage UR(DC)	10V
Tan δ	≦10%
Insulation resistance after 1 minute at U _R (DC)	Rins. $x C \ge 100 \Omega \cdot F$
Maximum capacitance change as	±15%
a function of temperature	
Terminations	Ni/Sn Barrier
Resistance to soldering heat	260°C, 10 sec

STORAGE CONDITIONS

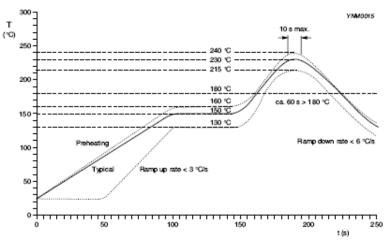
The products must be stored and shipping in an ambient temperature of less than 40°C with a relative humidity of less than 70%.





METHOD OF MOUNTING

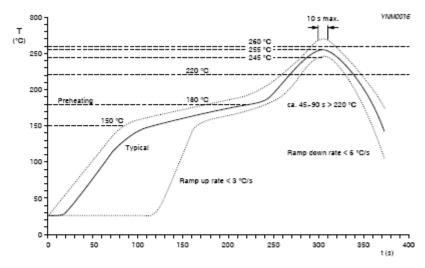
For normal use the capacitors may be mounted on printed-circuit boards or ceramic substrates by applying wave soldering, reflow soldering or conductive adhesive in accordance with "IEC 61760-1" (Standard method for the specification of surface mounting components).



Solid line: Typical process (terminal temperature)

Dotted lines: Process limits - bottom process limit (terminal temperature) & upper process limit (top surface temperature).

Infrared soldering, forced gas convection reflow soldering - Temperature/time profile for SnPb solders

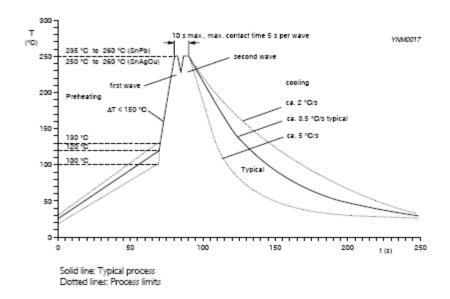


Solid line: Typical process (terminal temperature)

Dotted lines: Process limits - bottom process limit (terminal temperature) & upper process limit (top surface temperature).

Infrared soldering, forced gas convection reflow soldering - Temperature/time profile for lead-free SnAgCu solders





Double wave soldering for SnPb and lead-free SnAgCu solder - Temperature/time profile (terminal temperature)

SOLDERING RECOMMENDATION

Soldering Method	Size					
	0201	0402	0603	0805	1206	≥ 1210
Reflow	Reflow only	\geqq 0.1 uF	\geqq 1.0 uF	\geqq 2.2 uF	\geqq 4.7 uF	Reflow only
Reflow / Wave		< 0.1 uF	< 1.0 uF	< 2.2 uF	< 4.7 uF	



Test procedures and requirements.

IEC 60	cedures and requ TEST	PROCEDURE	REQUIREMENTS	REQUIREMENTS
384-21/22			General	High Cap.
4.3	Mounting	The capacitors may be mounted on printed-circuit boards or ceramic substrates	No visible damage	No visible damage
4.4	Visual inspection and dimension check	Any applicable method using x10 magnification	In accordance with specification	In accordance with specification
4.5.1	Capacitance	Class1: $C \leq 1nF, f = 1 \text{ MHz}; \\ C > 1nF, f = 1 \text{ KHz}; \\ NP0: measuring voltage 1 V at 20^{\circ}C Class 2: C \leq 10uF, V > 6.3V, f = 1 \text{ KHz}; measuring voltage 1 V at 20^{\circ}C C \leq 10uF, V \leq 6.3V, f = 1 \text{ KHz}; measuring voltage } 0.5 \text{ V at } 20^{\circ}C C \leq 10uF, f = 120\text{Hz}; measuring voltage } 0.5V \text{ at } 20^{\circ}C$	Within specified tolerance	Within specified tolerance CC0402MRX5R6BB475: F=1kHz, measuring voltage V=0.5V at 20℃.
4.5.2	Dissipation Factor (D.F.)	Class1: $C \le 1nF$, $f = 1$ MHz; $C > 1nF$, $f = 1$ KHz; NP0: measuring voltage 1 V at 20 °C Class 2: $C \le 10uF$, $f = 1$ KHz; measuring voltage 1 V at 20 °C $C > 10uF$, $f = 120Hz$; measuring voltage 0.5V at $C > 10uF$,	In accordance with specification	In accordance with specification CC0402MRX5R6BB475: F=1kHz, measuring voltage V=0.5V at 20℃.
4.5.3	Insulation resistance	At Ur (DC) for 1 minute	In accordance with specification	In accordance with specification
4.5.4	Voltage proof	Specified stress voltage applied for 1 minute Ur≤100V: series applied 2.5Ur 100 <ur≤200 (1.3ur="" (1.5ur="" +100)="" 200<ur≤500="" applied="" series="" ur="">500: 1.3Ur I: 7.5mA</ur≤200>	No breakdown or flashover	No breakdown or flashover
4.6	Temperature coefficient	Capacitance shall be measured by the steps shown in the following table. The capacitance change should be measured after 5 min at each specified temperature stage.	Class1: Δ C/C: ±30ppm Class2: X7R: Δ C/C: ±15% Y5V: Δ C/C: 22~-82%	Class2: X7R/X5R: ∆ C/C: ±15% Y5V: ∆ C/C: 22~-82% In case of applying voltage, the capacitance change should be measured after 1 more min. with applying voltage in equilibration of each temp. stage. CC0100MRX5R5BB104: 0.2V±0.1Vrms



Test procedures and requirements.

IEC 60 384-21/22	TEST	PROCEDURE	REQUIREMENTS General	REQUIREMENTS High Cap.
4.7	Adhesion	A force applied for 10 sec to the line joining the terminations and in a plane parallel to the substrate.	Force size ≥ 0603: ≥5N size = 0402: ≥2.5N size = 0201: ≥1N	Force size ≥ 0603: ≥ 5N size = 0402: ≥ 2.5N size = 0201: ≥ 1N
4.8	Bond strength of plating on end face	Mounting in accordance with IEC 60384-22 paragraph 4.3 Conditions: bending 1 mm at a rate of 1 mm/s, radius jig 340 mm	No visible damage Δ C/C Class1: NP0 within ±1% or 0.5 pF, whichever is greater Class2: X7R/Y5V: ±10%	No visible damage Δ C/C Class2: X5R/X7R/Y5V: ±10%
4.9	Resistance to soldering heat	Precondition: 150 +0/-10°C/1 hr, then keep for 24±1 hrs at room temp Preheating: for size ≤1206:120 to 150°C for 1 minute; Preheating: for size >1206:100 to 120 °C for 1 minute and 170 to 200°C for 1 minute. Solder bath temperature: 260 ± 5°C; Dipping time 10±0.5 s Recovery time 24±2 Hours.	Dissolution of the end face plating shall not exceed 25% of the length of the edge concerned. ΔC/C: Class1: NP0: within ±0.5% or 0.5 pF whichever is greater Class2: X7R/X5R: ±10% Y5V/Z5U: ±20% D.F.: within initial specified value R _{ins} : within initial specified value	Dissolution of the end face plating shall not exceed 25% of the length of the edge concerned. ΔC/C: Class2: X7R/X5R: ±10% Y5V: ±20% D.F.: within initial specified value R _{ins} : within initial specified value
4.10	Solderability	The specimen shall be preheated to a temperature of (80 to 140) $^{\circ}$ C and maintained for 30s to 60s. 1. Temperature: 235±5 $^{\circ}$ C / Dipping time: 2 ±0.5 s 2. Temperature: 245±5 $^{\circ}$ C / Dipping time: 3 ±0.5 s (lead free) Depth of immersion: 10mm	The solder should cover over 95% of the critical area of each termination.	The solder should cover over 95% of the critical area of each termination.
4.11	Rapid change of temperature	Preconditioning; 150 +0/-10°C/1 hr, then keep for24±1 hrs at room temp 5 cycles with following detail: 30 minutes at Lower Category Temperature; 30 minutes at Upper Category Temperature; Recovery time 24±2 Hours.	No visual damage ΔC/C: Class1: NP0: within 1% or 1 pF, whichever is greater Class2: X7R/X5R: ±15% Y5V/Z5U: ±20% D.F.: meet initial specified value R _{ins} : meet initial specified value	No visual damage; \$\Delta\$ C/C: Class2: X7R/X5R: \pm 15% Y5V: \pm 20% D.F.: meet initial specified value R_ins: meet initial specified value



Test procedures and requirements.

IEC 60	cedures and req TEST	PROCEDURE	REQUIREMENTS	REQUIREMENTS
384-21/22			General	High Cap.
				U = -11
4.13	Damp heat, with Ur	1. Preconditioning, class 2 only :	No visual damage after	No visual damage after
	load	150 +0/-10℃ /1 hr , then keep for 24±1hrs	recovery	recovery
		at room temp	ΔC/C :	AC/C:
		2. Initial measure		ΔC/C:
		Spec: refer Initial spec (C, D, IR)	NP0: within ±2% or 1 pF, whichever is greater	X7R/X5R: ±20% Y5V/Z5U: ±30%
			X7R/X5R : ±15%	13V/23U : ±3U%
		3. Damp heat test:	Y5V/Z5U: ±30%	
		500±12 hours at 40±2°C; 90 to 95% R.H.;	101/200 200/3	D.F.:
		1.0Ur applied.	D.F. :	2 x initial value max
		4 Booyen	NP0: 2 × specified value	
		4. Recovery. Class 1: 6 to 24 hours	X7R/X5R:	R _{ins} :
		Class 2 : 24±2 hours	≦16V : ≦7%	500 MΩ or Rins x Cr ≥ 10 s,
		Class 2 · 24±2 flours	≥25V : ≤5%	whichever is less
		5. Final measure:	Y5V∶≦15%	
		C, D, IR	Z5U∶≦12.5%	CC0100MRX5R5BB104:
				ΔC/C:
		P.S. If the capacitance value is less than the	R _{ins} :	X5R: ±25%
		minimum value permitted, then after the other	NP0:	
		measurements have been made the capacitor shall be precondition according to IEC 60384		D.F.:
		4.1 and then the requirement shall be met.	whichever is less X7R/X5R/Y5V:	2 x initial value max
		The and their the requirement shall be met.		R _{ins} :
			≥500MΩ or RxC≥25s whichever is less	Rins x Cr ≥ 5 s
			Z5U :	1 tine x or = 0 0
			≥1,000MΩ or RxC≥100s	
			whichever is less	
4.14	Endurance	1. Precondition, class 2 only:	No visual damage	No visual damage
		150 +0/-10 °C/1 hr , then keep for 24±1	AC/C:	A C/C:
		hrs at room temp	ΔC/C:	Δ C/C: Class2:
		2. Initial measure	NP0: within ±2% or 1 pF, whichever is greater	X7R/X5R: ±20%
		Spec: refer Initial spec	X7R/X5R : ± 15%	Y5V: ±30%
		C, D, IR	Y5V: ± 30%	
			Z5U: ± 30%	D.F.:
		3. Endurance test:		2 x initial value max
		Temperature: NP0/X7R: 125℃	D.F. :	R _{ins} :
		X5R/Y5V/Z5U:85 ℃	NP0: 2 × specified value	1000 MΩ or Rins x Cr \geq 10 s,
			X7R/X5R:	whichever is less
		Specified stress voltage applied for 1000	≤16V : ≤7%	
		hrs	≥25V : ≤5%	00040045755555
		Applied 2.0 x Ur for general product.	Y5V∶≦15%	CC0100MRX5R5BB104:
		Applied 1.5 x Ur for high cap. product.	Z5U∶≦12.5%	ΔC/C:
		High voltage series follows with below		X5R: ±25%
		stress condition:	R _{ins} :	D.F.:
		Applied 1.3 x Ur for 500V series	NPO:	2 x initial value max
		Applied 1.2 x Ur for 1KV, 2KV,3KV series.	≥4,000MΩ or RxC≥40s	
		A December times 24 to be seen	whichever is less X7R/Y5V/X5R:	R _{ins} :
		4. Recovery time: 24±2 hours	\geq 1000M Ω or RxC \geq 50s	Rins x Cr ≥ 10 s
		5. Final measure: C ,D, IR	whichever is less	
		o. r marmododio. O ,D, iix	Z5U :	
			\geq 1,000M Ω or RxC \geq 100s	
		P.S. If the capacitance value is less than the	whichever is less	
		minimum value permitted, then after the other		
		measurements have been made the capacitor		
		shall be precondition according to IEC 60384		
		4.1 and then the requirement shall be met.		